

Search Notes**Application/Control No.**

10/539,699

Examiner

Huyen Le

Applicant(s)/Patent under Reexamination

GREZ ET AL.

Art Unit

3751

SEARCHED

Class	Subclass	Date	Examiner
401	155 161 169 171	9/11/2007	HL
	176 179		
	183-185		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

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